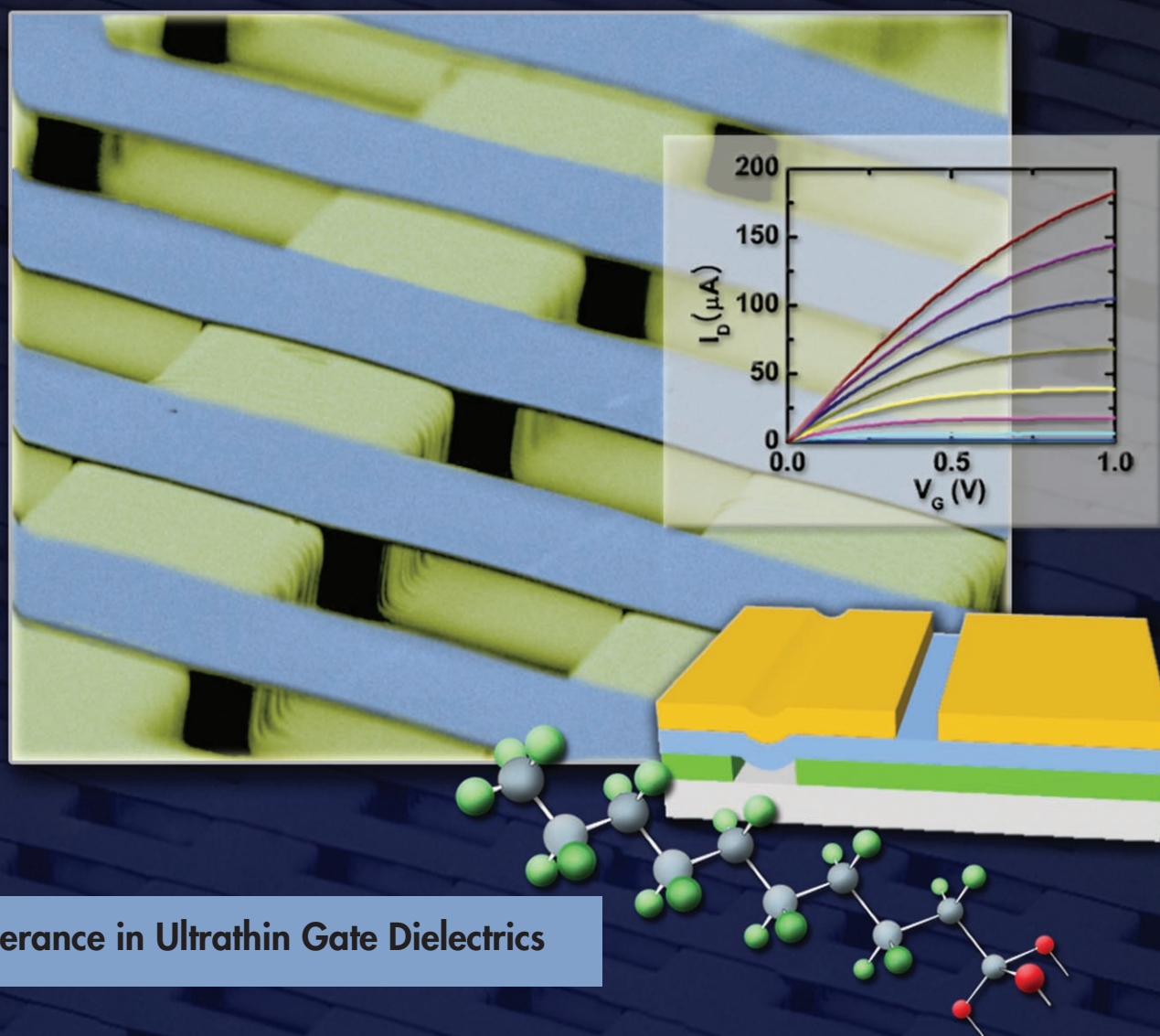


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# ADVANCED FUNCTIONAL MATERIALS



Defect Tolerance in Ultrathin Gate Dielectrics